



CERTIFICATE OF ACCREDITATION

The ANSI National Accreditation Board

Hereby attests that

1Source Metrology Corp.

**465 Pinebush Rd. Unit #2
Cambridge, Ontario, N1T 2J4**

Fulfills the requirements of

ISO/IEC 17025:2017

In the fields of

CALIBRATION and DIMENSIONAL MEASUREMENT

This certificate is valid only when accompanied by a current scope of accreditation document.
The current scope of accreditation can be verified at www.anab.org.

A handwritten signature in black ink, appearing to be 'J. Stine', is positioned above a horizontal line.

Jason Stine, Vice President

Expiry Date: 21 May 2027

Certificate Number: AD-2678



This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017.
This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory
quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017

1Source Metrology Corp

465 Pinebush Rd. Unit #2
Cambridge, Ontario, N1T 2J4

Bill Reilly 905-469-8821

CALIBRATION AND DIMENSIONAL MEASUREMENT

ISO/IEC 17025 Accreditation Granted: **21 May 2025**

Certificate Number: **AD-2678**

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CALIBRATION

Length – Dimensional Metrology

Parameter / Equipment	Range	Expanded Uncertainty of Measurement (+/-) ²	Reference Standard, Method and/or Equipment
Coordinate Measuring Machines (CMMs) — CMMs Used for Measuring Linear Dimensions ¹	(10 to 1 010) mm	$(1.4 + 0.004\ 4L)\ \mu\text{m}$	ISO 10360-2 using Step Gauges as references
Coordinate Measuring Machines (CMMs) — CMMs Used for Measuring Linear Dimensions ¹	(10 to 5 000) mm	$(1.5 + 0.004L)\ \mu\text{m}$	ISO 10360-2 using Laser Interferometer and Gauge Block as references
Profile Projectors ¹			
Length (X & Y axis)	(5 to 300) mm	$(2.4 + 0.003L)\ \mu\text{m}$	JIS B 7184 using Glass Scales, squareness standard and protractor as references
Squareness between X axis and Y axis	X/Y travel up to 100 mm	3.2 μm	
Angle	0° to 180°	0.017°	

Length – Dimensional Metrology

Parameter / Equipment	Range	Expanded Uncertainty of Measurement (+/-) ²	Reference Standard, Method and/or Equipment
Thread Plug Gauges			ASME B1-16M & ASME B1-2 using Trimos ULM, Gauge Blocks and Thread Wires as references
Pitch Diameter	Up to 304.8 mm	$(1.2 + 0.005L) \mu\text{m}$	
Major Diameter	Up to 304.8 mm	$(0.3 + 0.009L) \mu\text{m}$	
Adjustable Thread Ring Gauges	Up to 101.6 mm	$(7.3 + 5.9L) \mu\text{m}$	ASME B1-16M & ASME B1-2 using Calibrated Master Set Plugs as references
Plain Plug/Pin Gauges	(0.1 to 304.8) mm	$(0.3 + 0.009L) \mu\text{m}$	ASME B89-1-5 using Trimos ULM and Gauge Blocks as reference
Plain Ring Gauges	(12.7 to 304.8) mm	$(0.2 + 0.009L) \mu\text{m}$	ASME B89-1-6 using Trimos ULM and master rings as references
Pipe Taper Thread Plug Gauges			
Simple Pitch Diameter	Up to 304.8 mm Up to 12 in	$(1.5 + 0.003L) \mu\text{m}$	ASME B1-20-1 using Trimos ULM, thread wires, height gauge and gauge blocks as references
Basic Step Length	Up to 34.55 mm Up to 1.36 in	$(5.3 + 0.001L) \mu\text{m}$	
Taper per Thread	Up to 0.2 mm	4.3 μm	
Pipe Taper Thread Ring Gauges			
Standoff Height	Up to 50.8 mm Up to 2 in	9.3 μm	ASME B1-20-1 using master NPT set plugs, height gauge and gauge blocks as references
Ring Thickness	Up to 50.8 mm	$(5.3 + 0.001L) \mu\text{m}$	
Solid Thread Ring Gauges			ASME B1-16M & ASME B1-2 using Trimos ULM with touch probe and master rings as references
Pitch Diameter	Up to 152.4 mm Up to 6 in	$(2.4 + 0.0002L) \mu\text{m}$	

Length – Dimensional Metrology

Parameter / Equipment	Range	Expanded Uncertainty of Measurement (+/-) ²	Reference Standard, Method and/or Equipment
Solid Thread Ring Gauges Minor Diameter	Up to 152.4 mm Up to 6 in	$(3.4 + 0.003L) \mu\text{m}$	ASME B1-16M & ASME B1-2 using Zeiss Contura CMM as reference standard.
Granite Surface Plates ¹ Overall Flatness Flatness of Local Area	Diagonal: Up to 6 000 mm Up to 0.5 mm	$(1.3 + 0.1D) \mu\text{m}$ $0.23 \mu\text{m}$	Fed GGG-P-463c using Tesa TT20 & Autocollimator (D is the length of the diagonal in meters)
Gauge Blocks	1 mm to 101.6 mm	$(0.1 + 0.004 1L) \mu\text{m}$	ASME B89.1.9 and ISO 3650 Using Gauge Block Comparator and Master Gauge Blocks as references
Gauge Blocks	(>101.6 to 508) mm (> 4 to 20) in	$(0.6 + 0.004 2L) \mu\text{m}$	ASME B89.1.9 and ISO 3650 Using Trimos ULM and Master Gauge Blocks as references
Calipers (Outside and Inside Measurements)	(0 to 1 016) mm	$(2 + 0.01L) \mu\text{m} + 0.6R$	ASME B89.1.14 using Gauge Blocks as references
Outside Micrometers	(0 to 25.4) mm (25.4 to 609.6) mm	$0.51 \mu\text{m} + 0.007L + 0.6R$ $0.15 \mu\text{m} + 0.01L + 0.6R$	ASME B89.1.13 using Gauge Blocks as references
Inside Micrometers Extension Rods	(25 to 1 000) mm (1 to 40) in (25 to 1 000) mm (1 to 40) in	$1.7 \mu\text{m} + 0.007 2L + 0.6R$ $(1.2 + 0.021L) \mu\text{m}$	ASME B89.1.13 using Gauge blocks and Trimos ULM as reference
Depth Micrometers	(0 to 25.4) mm	$0.52 \mu\text{m} + 0.004L + 0.6R$	ASME B89.1.13 using Gauge Blocks as references
Height Gauges ¹	(0 to 914.4) mm	$4.8 \mu\text{m} + 0.006 7L + 0.6R$	JIS B 7517 using gauge Blocks and/or Step Gauges as references
Dial Indicators (Mechanical and Electronic Types)	(0 to 25.4) mm	$1.3 \mu\text{m} + 0.002 2L + 0.6R$	ASME B89.1.10M using Trimos ULM as reference

Length – Dimensional Metrology

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Test Indicators	(0 to 10) mm	1.3 μm + 0.01L + 0.6R	ASME B89.1.10M using Trimos ULM as reference
Snap Gauges (Adjustable/Fixed)	(0 to 500) mm	(2.3 + 0.01L) μm	Internal procedure WI-25 using Gauge Blocks as reference and CMM as direct measurement
Micrometer Setting Standards	(25 to 1 000) mm	(1.2 + 0.021L) μm	Internal procedure WI-27 using Universal Measuring Machine.
Universal Length Measuring Machines (ULMs)	(10 to 1 000) mm	(0.024 + 0.004 8L) μm	Comparison to Laser Interferometer

Mass and Mass Related

Parameter / Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method and/or Equipment
Indirect Verification of Rockwell Hardness Testers ¹	HRA: Low Medium High	0.48 HRA 0.54 HRA 0.35 HRA	Indirect verification method per ASTM E18
	HRC: Low Medium High	0.49 HRC 0.74 HRC 0.38 HRC	
	HREW: Low Medium High	0.66 HREW 0.75 HREW 0.63 HREW	
	HRBW: Low Medium High	1.20 HRBW 0.81 HRBW 0.55 HRBW	

Mass and Mass Related

Parameter / Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method and/or Equipment
Indirect Verification of Rockwell Hardness Testers ¹	HR15N: Low Medium High	0.49 HR15N 0.71 HR15N 0.31 HR15N	Indirect verification method per ASTM E18
	HR30TS: Low Medium High	0.83 HR30TS 0.68 HR30TS 0.55 HR30TS	
	HR30N: Low Medium High	0.49 HR30N 0.86 HR30N 0.40 HR30N	
	HR15TW: Low Medium High	0.61 HR15TW 0.47 HR15TW 0.58 HR15TW	
	HR30TW: Low Medium High	0.74 HR30TW 0.45 HR30TW 0.50 HR30TW	
	HR45N: Low Medium High	0.66 HR45N 0.82 HR45N 0.44 HR45N	
	HR45TW: Low Medium High	0.77 HR45TW 0.52 HR45TW 0.57 HR45TW	

DIMENSIONAL MEASUREMENT

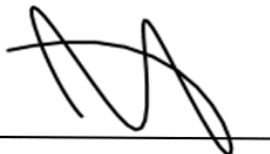
3 Dimensional

Parameter	Range	Expanded Uncertainty of Measurement (+/-) ²	Reference Standard, Method and/or Equipment
Dimensional Measurement 3D	X: Up to 1 200 mm Y: Up to 2 000 mm Z: Up to 1 000 mm	$(4.2 + 0.03L) \mu\text{m}$	Measurement using Coordinate Measuring as Reference Standard for Dimensional Measurement
Dimensional Measurement 3D	X: Up to 700 mm Y: Up to 1 000 mm Z: Up to 700 mm	$(3.2 + 0.03L) \mu\text{m}$	Measurement using Coordinate Measuring as Reference Standard for Dimensional Measurement
Dimensional Measurement 3D	X: Up to 1 000 mm Y: Up to 1 000 mm Z: Up to 600 mm	$(2.5 + 0.03L) \mu\text{m}$	Measurement using Coordinate Measuring as Reference Standard for Dimensional Measurement

Calibration and Measurement Capability (CMC) is expressed in terms of the measurement parameter, measurement range, expanded uncertainty of measurement and reference standard, method, and/or equipment. The expanded uncertainty of measurement is expressed as the standard uncertainty of the measurement multiplied by a coverage factor of 2 ($k=2$), corresponding to a confidence level of approximately 95%.

Notes:

1. On-site calibration service is available for this parameter, since on-site conditions are typically more variable than those in the laboratory, larger measurement uncertainties are expected on-site than what is reported on the accredited scope.
2. L is the length of object under calibration or measurement in mm. R is the resolution of the device under calibration in μm .



Jason Stine, Vice President